

ON Semiconductor®

FDB86366-F085

N-Channel PowerTrench® MOSFET **80 V, 110 A, 3.6 m**Ω

Features

- Typical R_{DS(on)} = 2.8 mΩ at V_{GS} = 10V, I_D = 80 A
- Typical $Q_{g(tot)}$ = 86 nC at V_{GS} = 10V, I_D = 80 A
- UIS Capability
- RoHS Compliant
- Qualified to AEC Q101

Applications

- Automotive Engine Control
- PowerTrain Management
- Solenoid and Motor Drivers
- Integrated Starter/Alternator
- Primary Switch for 12V Systems



MOSFET Maximum Rating unless scherwise noted.

Symbol	rameter	Ratings	Units
V_{DSS}	Drain-to-Sr , ce Voltage	80	V
V_{GS}	Gate-to-Sc rice Volta :	±20	V
	r un currei Con⁴ uous (V _{GS} = 12) (Note 1) T _C = 25° €	110	Α
ID	n Current 7 _C = 25°C	See Figure 4	_ ^
Eng	Single Pi Avalanch e Energy (Note 2)	178	mJ
1p	'owe. Ussipation	176	W
P_{D}	L _rate Abo re 2 ⁵ °C	1.2	W/°C
T_{J}, T_{G}	Operating and Storage Temperature	-55 to + 175	°C
, JC	Thermal Resistance, Junction to Case	0.85	°C/W
$R_{\theta J' \lambda}$	Maximum 1 hermal Resistance, Junction to Ambient (Note 3)	43	°C/W

- 1: Current is limited by 50 nc vire configuration.
 2: Starting T_J = 25°C, L = 57JH, I_{AS} = 64A, V_{DD} = 80V during inductor charging and V_{DD} = 0V during time in avalanche.
 3: R_{0,JA} is the sum of the junction-to-case and case-to-ambient thermal resistance, where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design, while $R_{\theta JA}$ is determined by the board design. The maximum rating presented here is based on mounting on a 1 in² pad of 2oz copper.

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDB86366	FDB86366-F085	D2-PAK(TO-263)	330mm	24mm	800units

Units

Max.

Electrical Characteristics $T_J = 25$ °C unless otherwise noted.

Parameter

Off Characteristics								
B _{VDSS}	Drain-to-Source Breakdown Voltage	$I_D = 250 \mu A$,	V _{GS} = 0V	80	-	-	V	
	Drain-to-Source Leakage Current	V _{DS} =80V,	$T_{\rm J} = 25^{\rm o}{\rm C}$	-	-	1	μΑ	
IDSS		$V_{GS} = 0V$	$T_J = 175^{\circ}C \text{ (Note 4)}$	-	-	1	mA	
I _{GSS}	Gate-to-Source Leakage Current	$V_{GS} = \pm 20V$,	-	-	±100	nA	

Test Conditions

Min.

Тур.

On Characteristics

Symbol

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, I	_D = 250μA	2.0	3 ^		V
R _{DS(on)}	Drain to Source On Registance	I _D = 80A,	$T_J = 25^{\circ}C$	-	2.	3.0	mΩ
		V _{GS} = 10V	$T_J = 175^{\circ}C \text{ (Note 4)}$		5.5	7.0	mΩ

Dynamic Characteristics

			1
C _{iss}	Input Capacitance	0280 -	pF
C _{oss}	Output Capacitance	$V_{DS} = 40V, V_{GS} = 0V,$ $f = 1MHz$	pF
C _{rss}	Reverse Transfer Capacitance	- 32 -	pF
R_g	Gate Resistance	f = 1MH ⁻ - 2.1 -	Q
$Q_{g(ToT)}$	Total Gate Charge	V _C to 10 = 64V - 86 112	UC.
$Q_{g(th)}$	Threshold Gate Charge	$V_{GS} = 2V$ $I_D = 80A$ - 12	nC
Q_{gs}	Gate-to-Source Gate Charge	- 30	nC
Q_{gd}	Gate-to-Drain "Miller" Charge	- 18/ -	nC

Switching Characteristic

t _{on}	Turn-On Tir	-	-	144	ns
t _{d(on)}	Turn-On [lay	1	30	1	ns
t_r	$V_{DD} = 40 \text{ V, } I_D = 80 \text{A,}$	1	76	1	ns
t _{d(off)}	urn-O" Delc $V_{32} = 10V$, $R_{GEN} = 6\Omega$	1	40	1	ns
t _f	I will Time	-	17	-	ns
	Tu' of time	-	-	83	ns

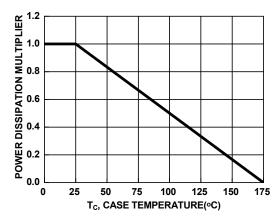
Drai. So. ce Dicge Characterisacs

	Source-to-Prain Didue Voltage	I _{SD} =80A, V _{GS} = 0V	-	-	1.25	V
טכי	Scurse-to-1.4.1 Disde Voltage	I_{SD} = 40A, V_{GS} = 0V	-	-	1.2	V
t _{r:}	Reverse-Recovery (in)e	I _F = 80A, dI _{SD} /dt = 100A/μs	-	67	87	ns
\mathcal{O}^{LL}	Reverse-Recovery Charge	V _{DD} = 64V	-	80	104	nC

Note:

4: The maximum value 13 specified by design at T_J = 175°C. Product is not tested to this condition in production.

Typical Characteristics



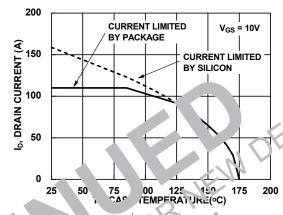
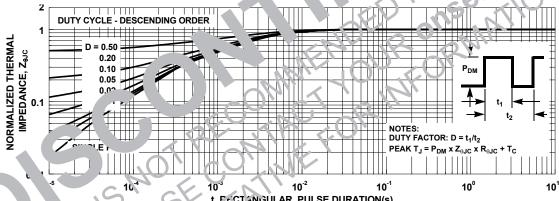


Figure 1. Normalized Power Dissipation vs. Case Temperature

num Cor tin Jous Drain Current vs.
Case Temperature



t, RECT ANGULAR PULSE DURATION(s)
Figure 3. Normalized Maximum Transient Thermal Impedance

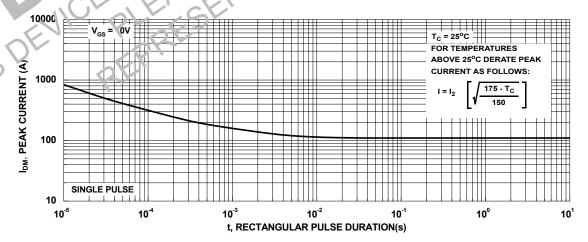


Figure 4. Peak Current Capability

Typical Characteristics

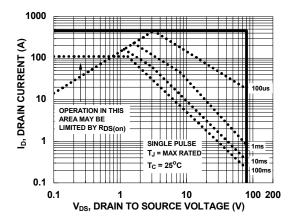
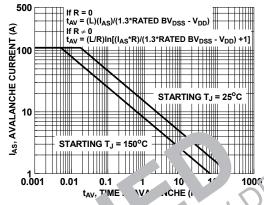
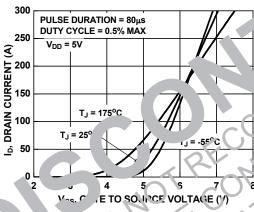


Figure 5. Forward Bias Safe Operating Area



NOTE: Refer to ON Sem. nduc Applir on Note: AN75 + and AN7515

Figure Un 'ampe Inductive Switching Car Jility



F. re 7. Transfer Characteristics

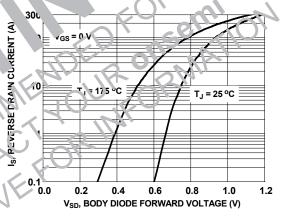


Figure 8. Forward Diode Characteristics

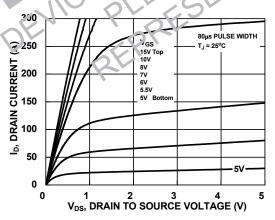


Figure 9. Saturation Characteristics

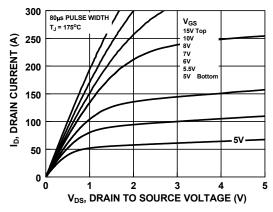


Figure 10. Saturation Characteristics

Typical Characteristics

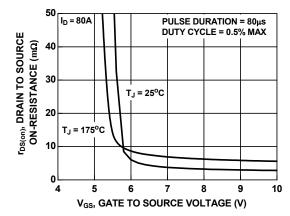


Figure 11. R_{DSON} vs. Gate Voltage

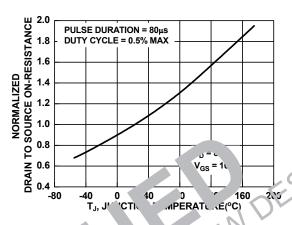
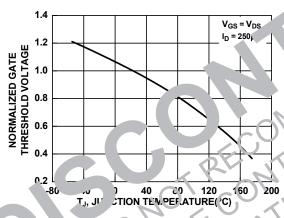


Figure 12 Norma rea SON vs. Junction Ten erature



Figu 15 Iormalized Gate Threshold Voltage vs.

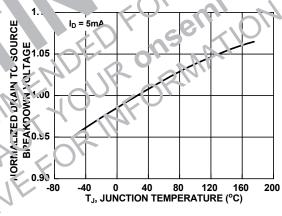


Figure 14. Normalized Drain to Source Breakdown Voltage vs. Junction Temperature

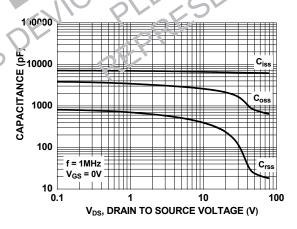


Figure 15. Capacitance vs. Drain to Source Voltage

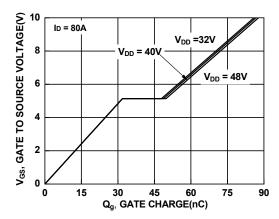


Figure 16. Gate Charge vs. Gate to Source Voltage



ON Semiconductor and III) are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns me rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdt/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages.

Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that ON Semiconductor was negligent regarding the design or manufacture of the part. ON Semiconductor is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada

Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free USA/Canada

Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910 Japan Customer Focus Center Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative